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First Named Inventor or Application Identifier

Jiang Hsieh

Title

METHODS AND APPARATUS FOR HELICAL RECONSTRUCTION
MULTISLICE CT SCAN

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(Only for new nonprovisional applications under 37 CFR 1.53(b))

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 - Background of the Invention
 - Brief Summary of the Invention
 - Brief Description of the Drawings (if filed)
 - Detailed Description
 - Claim(s)
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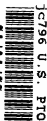
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METHODS AND APPARATUS FOR HELICAL RECONSTRUCTION FOR MULTISLICE CT SCAN

BACKGROUND OF THE INVENTION

This invention relates generally to methods and apparatus for computed tomographic (CT) imaging, and more specifically to methods and apparatus for acquiring and reconstructing helically scanned, medical CT images using a multi-slice CT imaging system.

5 In at least one known computed tomography (CT) imaging system configuration, an x-ray source projects a fan-shaped beam which is collimated to lie within an X-Y plane of a Cartesian coordinate system and generally referred to as the "imaging plane". The x-ray beam passes through the object being imaged, such as a patient. The beam, after being attenuated by the object, impinges upon an array of
10 radiation detectors. The intensity of the attenuated beam radiation received at the detector array is dependent upon the attenuation of the x-ray beam by the object. Each detector element of the array produces a separate electrical signal that is a measurement of the beam attenuation at the detector location. The attenuation measurements from all the detectors are acquired separately to produce a transmission profile.

15 In known third generation CT systems, the x-ray source and the detector array are rotated with a gantry within the imaging plane and around the object to be imaged so that the angle at which the x-ray beam intersects the object constantly changes. A group of x-ray attenuation measurements, i.e., projection data, from the
20 detector array at one gantry angle is referred to as a "view". A "scan" of the object comprises a set of views made at different gantry angles, or view angles, during one revolution of the x-ray source and detector. In an axial scan, the projection data is processed to construct an image that corresponds to a two dimensional slice taken through the object. In a helical scan, a table on which the object is resting moves so
25 that the object itself moves though the imaging plane while it is being scanned. A

multi-slice CT imaging system has a plurality of parallel detector rows configured to acquire attenuation measurements corresponding to one or more two-dimensional image slices of an object. The number of image slices and the thicknesses represented by the slices is dependent upon how (and whether) attenuation measurements from the parallel detector rows are combined.

One method for reconstructing an image from a set of projection data is referred to in the art as the filtered back projection technique. This process converts the attenuation measurements from a scan into integers called "CT numbers" or "Hounsfield units", which are used to control the brightness of a corresponding pixel on a cathode ray tube display.

Helical reconstruction algorithms for multi-slice CT have been a focus for many studies. In one known CT imaging system, a reconstruction algorithm is implemented for two special helical pitches: 3:1 and 6:1. This algorithm utilizes two conjugate samples from different detector rows to estimate projection samples at a reconstruction plane using linear interpolation. Although this method performs satisfactorily in many cases, it has a number of shortcomings. First, the sampling pattern is not always optimum because only two samples on either side of the plane of reconstruction are selected. For example, samples that are closer to the reconstruction plane but located on the same side of the plane will not be utilized. Second, a 3:1 helical pitch is non-optimal for projection sampling, because the first and last detector rows measure identical ray paths, reducing the amount of non-redundant information that is acquired. In fact, in one known helical reconstruction implementation, measured projections (after calibration) of these two rows are summed first before reconstruction takes place. Third, sharp structures in the original object (along a z-axis) are suppressed and degraded slice sensitivity profiles are obtained because linear interpolation suppresses high frequency information in the sampled data.

It would therefore be desirable to provide methods and apparatus for helical reconstruction in multi-slice CT imaging systems that overcome the above-described shortcomings of known image reconstruction systems.

BRIEF SUMMARY OF THE INVENTION

There is therefore provided, in one embodiment of the present invention, a method for imaging an object with a computed tomographic (CT) imaging system that includes steps of helically scanning the object with a multi-slice CT imaging system to acquire attenuation measurements of the object, the measurements including more than two conjugate samples for estimation of a projection at a plane of reconstruction of the object; and filtering and backprojecting the attenuation measurements of the object, including the more than two conjugate samples, to reconstruct at least one image slice of the object.

This embodiment and others provide, among other advantages, an improved sampling pattern and better use of the attenuation samples obtained during a scan.

BRIEF DESCRIPTION OF THE DRAWINGS

Figure 1 is a pictorial view of a CT imaging system.

Figure 2 is a block schematic diagram of the system illustrated in Figure 1.

Figure 3 is an illustration of a sampling pattern for image reconstruction in an embodiment of the invention employing a 2.5:1 helical pitch scan.

Figure 4 is an illustration of interpolation, extrapolation, and weighted interpolation-extrapolation techniques to estimate an attenuation value at a point x.

Figure 5 is a graph of slice sensitivity profile measurements using a thin slice phantom, comparing a slice profile using a known technique utilizing a 3:1 helical pitch scan to an embodiment of the present invention utilizing a 2.5:1 helical pitch scan.

DETAILED DESCRIPTION OF THE INVENTION

Referring to Figures 1 and 2, a computed tomograph (CT) imaging system 10 is shown as including a gantry 12 representative of a "third generation" CT scanner. Gantry 12 has an x-ray source 14 that projects a beam of x-rays 16 toward a detector array 18 on the opposite side of gantry 12. Detector array 18 is formed by detector elements 20 which together sense the projected x-rays that pass through an object 22, for example a medical patient. Detector array 18 may be fabricated in a single slice or multi-slice configuration. Each detector element 20 produces an electrical signal that represents the intensity of an impinging x-ray beam and hence the attenuation of the beam as it passes through patient 22. During a scan to acquire x-ray projection data, gantry 12 and the components mounted thereon rotate about a center of rotation 24.

Rotation of gantry 12 and the operation of x-ray source 14 are governed by a control mechanism 26 of CT system 10. Control mechanism 26 includes an x-ray controller 28 that provides power and timing signals to x-ray source 14 and a gantry motor controller 30 that controls the rotational speed and position of gantry 12. A data acquisition system (DAS) 32 in control mechanism 26 samples analog data from detector elements 20 and converts the data to digital signals for subsequent processing. An image reconstructor 34 receives sampled and digitized x-ray data from DAS 32 and performs high speed image reconstruction. The reconstructed image is applied as an input to a computer 36 which stores the image in a mass storage device 38.

Computer 36 also receives commands and scanning parameters from an operator via console 40 that has a keyboard. An associated cathode ray tube display 42 allows the operator to observe the reconstructed image and other data from computer 36. The operator supplied commands and parameters are used by computer 36 to provide control signals and information to DAS 32, x-ray controller 28 and gantry motor controller 30. In addition, computer 36 operates a table motor controller 44 which controls a motorized table 46 to position patient 22 in gantry 12.

Particularly, table 46 moves portions of patient 22 through gantry opening 48. During a helical scan, this motion occurs while scanning is taking place.

In one embodiment of the present invention, various shortcomings of known CT image reconstruction systems are overcome by using more than two conjugate samples for estimation of a projection at a plane of reconstruction (POR). This embodiment uses as many samples as the sampling pattern supports. The samples are located within a predetermined distance from the POR. Another feature of this embodiment is that non-integer pitch helical scans are performed for pitches that are numerically less than the number of detector rows. In other words, if the number of detector rows is N , a pitch $P:1$ is used, where P is not an integer, and $P < N$. For example, a 2.5:1 pitch is used in one embodiment having four detector rows so that no duplicated samples are acquired. Yet another feature of this embodiment is the use of nonlinear interpolation techniques to preserve high frequency image components. Examples of suitable nonlinear interpolation include Lagrange interpolation and weighted interpolation-extrapolation, among others. Interpolation takes place by weighting projections prior to the filtered backprojection.

In one embodiment and referring to Figure 3, a system 10 having four detector rows R1, R2, R3, and R4 is used with a 2.5:1 helical pitch. Sampling patterns are depicted as a function of projection view angle, detector angle, and detector row. $\beta_1, \beta_2, \beta_3$, and β_4 represent view angles at which corresponding detector rows R1, R2, R3, and R4 intersect a POR (not shown). These angles are arbitrarily selected, as only a relative angular span between them is important for any selected helical pitch. For this embodiment, an angular distance between adjacent rows that intersect the POR is 0.8π . In Figure 3, regions REG1, REG6, and REG11 are examples of conjugate regions, because samples in these regions differ in their view angles by either π or 2π . Each projection sample at the plane of reconstruction is estimated based on conjugate samples selected from three conjugate regions.

A "region 16" that would be located above REG15 could be included, since that region would also fall within a predetermined distance from POR.

However, "region 16" is excluded in this embodiment to provide improved temporal resolution. For each set of conjugated regions, three regions are included in this embodiment. If a "region 16" were included, the conjugate regions would include four regions 1, 6, 11 and 16. To provide the best temporal resolution, this embodiment seeks to formulate a smallest data set, in terms of view angle span, for image reconstruction. Including "region 16" would increase the entire angular span, as well as increase computation time and reduce uniformity.

Weights depend upon divisions of the region. To preserve symmetry and other properties, in one embodiment, projections are estimated along a curved plane written as $\beta'_1 = 2.8\pi - \gamma$, $\beta'_2 = 2\pi - \gamma$, $\beta'_3 = 1.2\pi - \gamma$, and $\beta'_4 = 0.4\pi - \gamma$, where $\beta'_1, \beta'_2, \beta'_3$, and β'_4 represent view angles in a curved plane for corresponding detector rows R1, R2, R3, and R4, respectively. Each curved plane is defined by boundary conditions given by regions cited in equations (1) to (4). In this notation, γ represents the detector angle. Weights for third-order Lagrange interpolation for rows R1, R2, R3, and R4, respectively, are written as:

$$w_1(\gamma, \beta) = \begin{cases} \frac{25}{6\pi^2} \left(\beta - \beta'_1 + \frac{2\pi}{5} \right) \left(\beta - \beta'_1 + \frac{3\pi}{5} \right) & \beta'_1 - \frac{2\pi}{5} \leq \beta < \beta'_1 - \frac{\pi}{5} \\ -\frac{25}{2\pi^2} \left(\beta - \beta'_1 + \frac{2\pi}{5} \right) \left(\beta - \beta'_1 - \frac{\pi}{5} \right) & \beta'_1 - \frac{\pi}{5} \leq \beta < \beta'_1 \\ \frac{25}{2\pi^2} \left(\beta - \beta'_1 - \frac{2\pi}{5} \right) \left(\beta - \beta'_1 + \frac{\pi}{5} \right) & \beta'_1 \leq \beta < \beta'_1 + \frac{\pi}{5} \end{cases} \quad (1)$$

$$w_2(\gamma, \beta) = \begin{cases} \frac{25}{3\pi^2} \left(\beta - \beta'_2 + \frac{3\pi}{5} \right) \left(\beta - \beta'_2 + \frac{\pi}{5} \right) & \beta'_2 - \frac{2\pi}{5} \leq \beta < \beta'_2 - \frac{\pi}{5} \\ -\frac{25}{2\pi^2} \left(\beta - \beta'_2 - \frac{\pi}{5} \right) \left(\beta - \beta'_2 + \frac{\pi}{5} \right) & \beta'_2 - \frac{\pi}{5} \leq \beta < \beta'_2 \\ \frac{25}{2\pi^2} \left(\beta - \beta'_2 - \frac{2\pi}{5} \right) \left(\beta - \beta'_2 - \frac{\pi}{5} \right) & \beta'_2 \leq \beta < \beta'_2 + \frac{2\pi}{5} \end{cases} \quad (2)$$

$$w_3(\gamma, \beta) = \begin{cases} \frac{25}{2\pi^2} \left(\beta - \beta'_3 + \frac{\pi}{5} \right) \left(\beta - \beta'_3 + \frac{2\pi}{5} \right) & \beta'_3 - \frac{2\pi}{5} \leq \beta < \beta'_3 - \frac{\pi}{5} \\ -\frac{25}{\pi^2} \left(\beta - \beta'_3 - \frac{\pi}{5} \right) \left(\beta - \beta'_3 + \frac{\pi}{5} \right) & \beta'_3 - \frac{\pi}{5} \leq \beta < \beta'_3 + \frac{\pi}{5} \\ \frac{25}{3\pi^2} \left(\beta - \beta'_3 - \frac{\pi}{5} \right) \left(\beta - \beta'_3 - \frac{3\pi}{5} \right) & \beta'_3 + \frac{\pi}{5} \leq \beta < \beta'_3 + \frac{2\pi}{5} \end{cases} \quad (3)$$

$$w_4(\gamma, \beta) = \begin{cases} \frac{25}{2\pi^2} \left(\beta - \beta'_4 + \frac{\pi}{5} \right) \left(\beta - \beta'_4 + \frac{2\pi}{5} \right) & \beta'_4 - \frac{2\pi}{5} \leq \beta < \beta'_4 \\ -\frac{25}{2\pi^2} \left(\beta - \beta'_4 + \frac{\pi}{5} \right) \left(\beta - \beta'_4 - \frac{2\pi}{5} \right) & \beta'_4 \leq \beta < \beta'_4 + \frac{\pi}{5} \\ \frac{25}{6\pi^2} \left(\beta - \beta'_4 - \frac{3\pi}{5} \right) \left(\beta - \beta'_4 - \frac{2\pi}{5} \right) & \beta'_4 + \frac{\pi}{5} \leq \beta < \beta'_4 + \frac{2\pi}{5} \end{cases} \quad (4)$$

In one embodiment of the present invention, weighted interpolation-extrapolation (WIE), i.e., a combining of weighted interpolation measurements with weighted extrapolated measurements, is used prior to the filtered backprojection. Figure 4 illustrates an example having three sampling points that are located on both sides of a point x where the interpolation is to take place. (A different case in which one sample is located at left and two samples at the right is treated similarly.) For one known helical reconstruction algorithm, only x_2 and x_3 are used for linear interpolation represented by line 50. Weights t_2 and t_3 used for x_2 and x_3 , respectively, are written as:

$$\begin{aligned} t_2 &= \frac{x_3 - x}{x_3 - x_2} \\ t_3 &= \frac{x - x_2}{x_3 - x_2} \end{aligned} \quad (5)$$

In one embodiment of the present invention, to use points x_1 and x_2 to estimate x , extrapolation is used as represented by line 52. Weights for x_1 and x_2 (denoted by e_1 and e_2) are written as:

$$e1 = \frac{x2 - x}{x2 - x1}$$

$$e2 = \frac{x - x1}{x2 - x1}$$
(6)

In this notation, $x1$, $x2$, and $x3$ are x-axis coordinates of locations of measured signals, and x is the location of the signal to be estimated. The weights used in linear interpolation are calculated based on a relative distance of the two points to the interpolation location. Combined weights for points $x1$, $x2$, and $x3$ (denoted by $q1$, $q2$, and $q3$, respectively) are written as:

$$q1 = (1 - t_2^\alpha - t_3^\alpha) e1,$$

$$q2 = (1 - t_2^\alpha - t_3^\alpha) e2 + (t_2^\alpha + t_3^\alpha) t2,$$

$$q3 = (t_2^\alpha + t_3^\alpha) t3.$$
(7)

In equation (7), α is a parameter that adjusts relative strength and contributions of the extrapolation. The terms $q1$, $q2$, and $q3$ represent weights for the three measured samples to estimate a sample in the POR.

This interpolation scheme overcomes the shortcomings of linear interpolation and enables a better preservation of high frequency information contents. Weighting functions for rows R1, R2, R3, and R4, respectively, for this interpolation scheme, represented by line 54, are written as:

$$w_i(\gamma, \beta) =$$

$$\left\{ \begin{array}{ll} \left[\left(\frac{5\theta_1 + 2\pi}{2\pi} \right)^\alpha + \left(\frac{-5\theta_1}{2\pi} \right)^\alpha \right] \left(\frac{5\theta_1 + 2\pi}{2\pi} \right), & \beta'_1 - \frac{2\pi}{5} \leq \beta < \beta'_1 - \frac{\pi}{5} \\ \left[1 - \left(\frac{5\theta_1 + 2\pi}{2\pi} \right)^\alpha - \left(\frac{-5\theta_1}{2\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_1}{\pi} \right) + \\ \left[\left(\frac{5\theta_1 + 2\pi}{2\pi} \right)^\alpha + \left(\frac{-5\theta_1}{2\pi} \right)^\alpha \right] \left(\frac{5\theta_1 + 2\pi}{2\pi} \right), & \beta'_1 - \frac{\pi}{5} \leq \beta < \beta'_1 \\ \left[\left(\frac{5\theta_1}{\pi} \right)^\alpha + \left(\frac{\pi - 5\theta_1}{\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_1}{\pi} \right), & \beta'_1 \leq \beta < \beta'_1 + \frac{\pi}{5} \end{array} \right. \quad (8)$$

$$\text{where } \theta_1 = \beta - \beta'_1 = \beta - 2.8\pi + \gamma,$$

$$w_2(\gamma, \beta) =$$

$$\left\{ \begin{array}{ll} \left[1 - \left(\frac{5\theta_2 + 3\pi}{2\pi} \right)^\alpha - \left(\frac{-5\theta_2 - \pi}{2\pi} \right)^\alpha \right] \left(\frac{5\theta_2 + \pi}{\pi} \right), & \beta'_2 - \frac{2\pi}{5} \leq \beta < \beta'_2 - \frac{\pi}{5} \\ \left[1 - \left(\frac{5\theta_2 + \pi}{\pi} \right)^\alpha - \left(\frac{-5\theta_2}{\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_2}{\pi} \right) + \\ \left[\left(\frac{5\theta_2 + \pi}{\pi} \right)^\alpha + \left(\frac{-5\theta_2}{\pi} \right)^\alpha \right] \left(\frac{5\theta_2 + \pi}{\pi} \right), & \beta'_2 - \frac{\pi}{5} \leq \beta < \beta'_2 \\ \left[\left(\frac{5\theta_2}{\pi} \right)^\alpha + \left(\frac{\pi - 5\theta_2}{\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_2}{\pi} \right), & \beta'_2 \leq \beta < \beta'_2 + \frac{\pi}{5} \\ \left[1 - \left(\frac{5\theta_2 - \pi}{\pi} \right)^\alpha - \left(\frac{2\pi - 5\theta_2}{\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_2}{\pi} \right), & \beta'_2 + \frac{\pi}{5} \leq \beta < \beta'_2 + \frac{2\pi}{5} \end{array} \right. \quad (9)$$

$$\text{where } \theta_2 = \beta - \beta'_2 = \beta - 2\pi + \gamma,$$

$$w_3(\gamma, \beta) =$$

$$\left\{ \begin{array}{ll} \left[1 - \left(\frac{5\theta_3 + 2\pi}{\pi} \right)^\alpha - \left(\frac{-5\theta_3 - \pi}{\pi} \right)^\alpha \right] \left(\frac{5\theta_3 + \pi}{\pi} \right) & \beta'_3 - \frac{2\pi}{5} \leq \beta < \beta'_3 - \frac{\pi}{5} \\ \left[1 - \left(\frac{5\theta_3 + \pi}{\pi} \right)^\alpha - \left(\frac{-5\theta_3}{\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_3}{\pi} \right) + \\ \left[\left(\frac{5\theta_3 + \pi}{\pi} \right)^\alpha + \left(\frac{-5\theta_3}{\pi} \right)^\alpha \right] \left(\frac{5\theta_3 + \pi}{\pi} \right) & \beta'_3 - \frac{\pi}{5} \leq \beta < \beta'_3 \\ \left[1 - \left(\frac{5\theta_3}{\pi} \right)^\alpha - \left(\frac{\pi - 5\theta_3}{\pi} \right)^\alpha \right] \left(\frac{\pi + 5\theta_3}{\pi} \right) + \\ \left[\left(\frac{5\theta_3}{\pi} \right)^\alpha + \left(\frac{\pi - 5\theta_3}{\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_3}{\pi} \right) & \beta'_3 \leq \beta < \beta'_3 + \frac{\pi}{5} \\ \left[1 - \left(\frac{5\theta_3 - \pi}{2\pi} \right)^\alpha - \left(\frac{3\pi - 5\theta_3}{2\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_3}{\pi} \right) & \beta'_3 + \frac{\pi}{5} \leq \beta < \beta'_3 + \frac{2\pi}{5} \end{array} \right. \quad (10)$$

where $\theta_3 = \beta - \beta'_3 = \beta - 1.2\pi + \gamma$, and

$$w_4(\gamma, \beta) = \begin{cases} \left[1 - \left(\frac{5\theta_4 + 2\pi}{\pi} \right)^\alpha - \left(\frac{-5\theta_4 - \pi}{\pi} \right)^\alpha \right] \left(\frac{5\theta_4 + \pi}{\pi} \right) & \beta'_4 - \frac{2\pi}{5} \leq \beta < \beta'_4 - \frac{\pi}{5} \\ \left[\left(\frac{5\theta_4 + \pi}{\pi} \right)^\alpha + \left(\frac{-5\theta_4}{\pi} \right)^\alpha \right] \left(\frac{\pi + 5\theta_4}{\pi} \right) & \beta'_4 - \frac{\pi}{5} \leq \beta < \beta'_4 \\ \left[1 - \left(\frac{5\theta_4}{2\pi} \right)^\alpha - \left(\frac{2\pi - 5\theta_4}{2\pi} \right)^\alpha \right] \left(\frac{\pi + 5\theta_4}{\pi} \right) + \\ \left[\left(\frac{5\theta_4}{2\pi} \right)^\alpha + \left(\frac{2\pi - 5\theta_4}{2\pi} \right)^\alpha \right] \left(\frac{2\pi - 5\theta_4}{2\pi} \right) & \beta'_4 \leq \beta < \beta'_4 + \frac{\pi}{5} \\ \left[\left(\frac{5\theta_4}{2\pi} \right)^\alpha + \left(\frac{2\pi - 5\theta_4}{2\pi} \right)^\alpha \right] \left(\frac{2\pi - 5\theta_4}{2\pi} \right) & \beta'_4 + \frac{\pi}{5} \leq \beta < \beta'_4 + \frac{2\pi}{5} \end{cases} \quad (11)$$

where $\theta_4 = \beta - \beta'_4 = \beta - 0.4\pi + \gamma$.

In equations (8)-(11), w1, w2, w3, and w4 are derived weights for four rows, based on conjugate regions shown in Figure 3 and in equation (7). For each sample to be estimated on POR, three conjugate samples are selected, based on Figure 3, and equation (7) is applied to determine their weights. The three conjugate samples could, for example, come from any three of R1, R2, R3, and R4.

To demonstrate the advantages of the use of the above reconstruction weights expressed in equations (8)-(11), a phantom study was performed. In this study, a thin plate placed parallel to an x-y plane inside a 20 cm poly phantom was scanned with 120kV/200mA/1.25mm/1sec at both 3:1 and 2.5:1 pitches. Images were reconstructed every 0.1mm to ensure adequate samples to map out slice profiles. For the 3:1 helical pitch, a known reconstruction algorithm was used. For the 2.5:1 helical pitch, the weights expressed in equations (8)-(11) were used. Profiles of the thin plates (and therefore, a system slice sensitivity profile) were calculated for both cases.

To avoid effects of statistical noise due to finite x-ray photon statistics, each point on a profile curve is an average over a 21 by 21 pixel region (in an x-y plane) centered on the thin plate. Figure 5 depicts a slice profile A for a 3:1 helical pitch image reconstructed using the known reconstruction algorithm and a slice profile B for a 2.5:1 helical pitch image reconstructed using the weight functions expressed in equations (8)-(11). A much narrower slice profile is obtained and the peak intensity for the profile is higher when equations (8)-(11) are used.

To more fully evaluate a WIE reconstruction embodiment of the present invention, a noise analysis was performed. For comparison, images in z of WIE were smoothed by a filter kernel such that WIE with smoothing provides the same slice profile as the known algorithm without smoothing. A kernel that satisfies this condition has been found to be an 11-point kernel with coefficients [0.5, 1, 1, ..., 1, 1, 0.5].

Image smoothing (in z) for the WIE images was also performed for a case in which the phantom was uniform in z. The standard deviation of the smoothed image was determined to be 5.23 HU. The standard deviation observed using the known algorithm was 6.63 HU. This result indicates that for the same slice sensitivity profile, a nearly 37% mA reduction can be achieved, if the noise is to be maintained at the same level. In images corresponding to the location where the thin plate is located, WIE-weighted images with smoothing show less image artifacts than images reconstructed using the known reconstruction algorithm.

In another embodiment, an equivalent result to a non-linear interpolation is achieved by multiplying a set of projection data by a set of weights. The weights, for a third order Lagrange interpolation, are written as equations (1)-(4), while weights for WIE are written as equations (8)-(11).

It will thus be seen that embodiments of the present invention provide better sampling patterns, acquire less redundant information, result in less suppression of sharp structures of object and better slice sensitivity profiles than known helical CT image reconstruction methods and systems.

Although the exemplary embodiments described herein and having test results presented herein are 4-slice embodiments, other embodiments of the invention are applicable to multi-slice CT imaging systems providing different numbers of image slices. For example, in other embodiments, 8-slice, 16-slice, 32-slice, etc. CT imaging systems are used. In addition, the invention is not limited to embodiments providing a 2.5:1 helical pitch. This pitch was selected for purposes of illustration only. Other embodiments of the invention are applicable to CT imaging systems providing different helical pitches. In addition, the CT system described herein is a "third generation" system in which both the x-ray source and detector rotate with the gantry. Many other CT systems including "fourth generation" systems wherein the detector is a full-ring stationary detector and only the x-ray source rotates with the gantry, may be used if individual detector elements are corrected to provide substantially uniform responses to a given x-ray beam.

While the invention has been described in terms of various specific embodiments, those skilled in the art will recognize that the invention can be practiced with modification within the spirit and scope of the claims. Accordingly, the spirit and scope of the invention are to be limited only by the terms of the appended claims.

WHAT IS CLAIMED IS:

1. A method for imaging an object with a computed tomographic (CT) imaging system, comprising the steps of:

helically scanning the object with a multi-slice CT imaging system to acquire attenuation measurements of the object, the measurements including more than two conjugate samples for estimation of a projection at a plane of reconstruction of the object; and

filtering and backprojecting the attenuation measurements of the object, including the more than two conjugate samples, to reconstruct at least one image slice of the object.

2. A method in accordance with Claim 1 wherein the more than two conjugate samples are located within a predetermined distance from the plane of reconstruction of the object.

3. A method in accordance with Claim 1 wherein the CT imaging system has N detector rows, and further comprising the step of selecting a helical pitch $P:1$ for said helical scan, where P is a non-integer less than N .

4. A method in accordance with Claim 3 wherein $N=4$ and $P=2.5$.

5. A method in accordance with Claim 1 further comprising the step of applying a non-linear interpolation to the attenuation measurements prior to said filtering and backprojecting.

6. A method in accordance with Claim 5 wherein applying a non-linear interpolation to the attenuation measurements comprises applying a Lagrange interpolation to the attenuation measurements.

7. A method in accordance with Claim 6 wherein applying a Lagrange interpolation to the attenuation measurements comprises applying third order Lagrange interpolation weights to measurements from four detector rows.

8. A method in accordance with Claim 5 wherein the CT imaging system has 4 detector rows, helically scanning the object to obtain attenuation measurements comprises the step of helically scanning the object at a pitch of 2.5:1, and said method further comprises the step of estimating projections along a curved plane written as $\beta'_1 = 2.8\pi - \gamma$, $\beta'_2 = 2\pi - \gamma$, $\beta'_3 = 1.2\pi - \gamma$, and $\beta'_4 = 0.4\pi - \gamma$, where β'_1 , β'_2 , β'_3 , and β'_4 represent view angles in a curved plane for corresponding detector rows R1, R2, R3, and R4, respectively, and γ represents a detector angle.

9. A method in accordance with claim 5 wherein applying a non-linear interpolation to the attenuation measurements comprises combining weighted interpolated measurements with weighted extrapolated measurements.

10. A method in accordance with Claim 9 wherein the CT imaging system has 4 detector rows R1, R2, R3, and R4, helically scanning the object to obtain attenuation measurements comprises the step of helically scanning the object at a pitch of 2.5:1, and said method further comprises the step of applying weights to attenuation measurements for detector rows R1, R2, R3, and R4 respectively, wherein the applied weights are written as:

$$w_1(\gamma, \beta) =$$

$$\left\{ \begin{array}{ll} \left[\left(\frac{5\theta_1 + 2\pi}{2\pi} \right)^\alpha + \left(\frac{-5\theta_1}{2\pi} \right)^\alpha \right] \left(\frac{5\theta_1 + 2\pi}{2\pi} \right), & \beta'_1 - \frac{2\pi}{5} \leq \beta < \beta'_1 - \frac{\pi}{5} \\ \left[1 - \left(\frac{5\theta_1 + 2\pi}{2\pi} \right)^\alpha - \left(\frac{-5\theta_1}{2\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_1}{\pi} \right) + \\ \left[\left(\frac{5\theta_1 + 2\pi}{2\pi} \right)^\alpha + \left(\frac{-5\theta_1}{2\pi} \right)^\alpha \right] \left(\frac{5\theta_1 + 2\pi}{2\pi} \right), & \beta'_1 - \frac{\pi}{5} \leq \beta < \beta'_1 \\ \left[\left(\frac{5\theta_1}{\pi} \right)^\alpha + \left(\frac{\pi - 5\theta_1}{\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_1}{\pi} \right), & \beta'_1 \leq \beta < \beta'_1 + \frac{\pi}{5} \end{array} \right.$$

$$\text{where } \theta_1 = \beta - \beta'_1 = \beta - 2.8\pi + \gamma,$$

$$w_2(\gamma, \beta) =$$

$$\left\{ \begin{array}{ll} \left[1 - \left(\frac{5\theta_2 + 3\pi}{2\pi} \right)^\alpha - \left(\frac{-5\theta_2 - \pi}{2\pi} \right)^\alpha \right] \left(\frac{5\theta_2 + \pi}{\pi} \right), & \beta'_2 - \frac{2\pi}{5} \leq \beta < \beta'_2 - \frac{\pi}{5} \\ \left[1 - \left(\frac{5\theta_2 + \pi}{\pi} \right)^\alpha - \left(\frac{-5\theta_2}{\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_2}{\pi} \right) + \\ \left[\left(\frac{5\theta_2 + \pi}{\pi} \right)^\alpha + \left(\frac{-5\theta_2}{\pi} \right)^\alpha \right] \left(\frac{5\theta_2 + \pi}{\pi} \right), & \beta'_2 - \frac{\pi}{5} \leq \beta < \beta'_2 \\ \left[\left(\frac{5\theta_2}{\pi} \right)^\alpha + \left(\frac{\pi - 5\theta_2}{\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_2}{\pi} \right), & \beta'_2 \leq \beta < \beta'_2 + \frac{\pi}{5} \\ \left[1 - \left(\frac{5\theta_2 - \pi}{\pi} \right)^\alpha - \left(\frac{2\pi - 5\theta_2}{\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_2}{\pi} \right), & \beta'_2 + \frac{\pi}{5} \leq \beta < \beta'_2 + \frac{2\pi}{5} \end{array} \right.$$

$$\text{where } \theta_2 = \beta - \beta'_2 = \beta - 2\pi + \gamma,$$

$$w_3(\gamma, \beta) =$$

$$\left\{ \begin{array}{ll} \left[1 - \left(\frac{5\theta_3 + 2\pi}{\pi} \right)^\alpha - \left(\frac{-5\theta_3 - \pi}{\pi} \right)^\alpha \right] \left(\frac{5\theta_3 + \pi}{\pi} \right) & \beta'_3 - \frac{2\pi}{5} \leq \beta < \beta'_3 - \frac{\pi}{5} \\ \left[1 - \left(\frac{5\theta_3 + \pi}{\pi} \right)^\alpha - \left(\frac{-5\theta_3}{\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_3}{\pi} \right) + \\ \left[\left(\frac{5\theta_3 + \pi}{\pi} \right)^\alpha + \left(\frac{-5\theta_3}{\pi} \right)^\alpha \right] \left(\frac{5\theta_3 + \pi}{\pi} \right) & \beta'_3 - \frac{\pi}{5} \leq \beta < \beta'_3 \\ \left[1 - \left(\frac{5\theta_3}{\pi} \right)^\alpha - \left(\frac{\pi - 5\theta_3}{\pi} \right)^\alpha \right] \left(\frac{\pi + 5\theta_3}{\pi} \right) + \\ \left[\left(\frac{5\theta_3}{\pi} \right)^\alpha + \left(\frac{\pi - 5\theta_3}{\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_3}{\pi} \right) & \beta'_3 \leq \beta < \beta'_3 + \frac{\pi}{5} \\ \left[1 - \left(\frac{5\theta_3 - \pi}{2\pi} \right)^\alpha - \left(\frac{3\pi - 5\theta_3}{2\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_3}{\pi} \right) & \beta'_3 + \frac{\pi}{5} \leq \beta < \beta'_3 + \frac{2\pi}{5} \end{array} \right.$$

where $\theta_3 = \beta - \beta'_3 = \beta - 1.2\pi + \gamma$, and

$$w_4(\gamma, \beta) =$$

$$\left\{ \begin{array}{ll} \left[1 - \left(\frac{5\theta_4 + 2\pi}{\pi} \right)^\alpha - \left(\frac{-5\theta_4 - \pi}{\pi} \right)^\alpha \right] \left(\frac{5\theta_4 + \pi}{\pi} \right) & \beta'_4 - \frac{2\pi}{5} \leq \beta < \beta'_4 - \frac{\pi}{5} \\ \left[\left(\frac{5\theta_4 + \pi}{\pi} \right)^\alpha + \left(\frac{-5\theta_4}{\pi} \right)^\alpha \right] \left(\frac{\pi + 5\theta_4}{\pi} \right) & \beta'_4 - \frac{\pi}{5} \leq \beta < \beta'_4 \\ \left[1 - \left(\frac{5\theta_4}{2\pi} \right)^\alpha - \left(\frac{2\pi - 5\theta_4}{2\pi} \right)^\alpha \right] \left(\frac{\pi + 5\theta_4}{\pi} \right) + \\ \left[\left(\frac{5\theta_4}{2\pi} \right)^\alpha + \left(\frac{2\pi - 5\theta_4}{2\pi} \right)^\alpha \right] \left(\frac{2\pi - 5\theta_4}{2\pi} \right) & \beta'_4 \leq \beta < \beta'_4 + \frac{\pi}{5} \\ \left[\left(\frac{5\theta_4}{2\pi} \right)^\alpha + \left(\frac{2\pi - 5\theta_4}{2\pi} \right)^\alpha \right] \left(\frac{2\pi - 5\theta_4}{2\pi} \right) & \beta'_4 + \frac{\pi}{5} \leq \beta < \beta'_4 + \frac{2\pi}{5} \end{array} \right.$$

$$\text{where } \theta_4 = \beta - \beta'_4 = \beta - 0.4\pi + \gamma,$$

$$\beta'_1 = 2.8\pi - \gamma, \beta'_2 = 2\pi - \gamma, \beta'_3 = 1.2\pi - \gamma, \text{ and } \beta'_4 = 0.4\pi - \gamma;$$

$\beta'_1, \beta'_2, \beta'_3,$ and β'_4 represent view angles intersecting the POR for

5 detector rows R1, R2, R3, and R4, respectively, and

γ represents a detector angle.

11. A method in accordance with Claim 1 further comprising the step of applying a set of weights to the attenuation measurements prior to said filtering and backprojecting.

10 12. A method in accordance with Claim 11 wherein applying a set of weights to the attenuation measurements comprises the step of applying Lagrange weights to the attenuation measurements.

13. A method in accordance with Claim 12 wherein applying Lagrange weights to the attenuation measurements comprises applying third order Lagrange weights to measurements from four detector rows.

14. A method in accordance with Claim 11 wherein the CT imaging system has 4 detector rows, helically scanning the object to obtain attenuation measurements comprises the step of helically scanning the object at a pitch of 2.5:1, and said method further comprises the step of estimating projections along a curved plane written as $\beta'_1 = 2.8\pi - \gamma$, $\beta'_2 = 2\pi - \gamma$, $\beta'_3 = 1.2\pi - \gamma$, and $\beta'_4 = 0.4\pi - \gamma$, where β'_1 , β'_2 , β'_3 , and β'_4 represent view angles in a curved plane for corresponding detector rows R1, R2, R3, and R4, respectively, and γ represents a detector angle.

15. A computed tomographic (CT) imaging system for imaging an object, said system comprising a radiation source and a multi-slice detector configured to acquire attenuation measurements of an object between said radiation source and said multi-slice detector, said system configured to:

helical scan the object to acquire attenuation measurements of the object, said measurements including more than two conjugate samples for estimation of a projection at a plane of reconstruction of the object; and

filter and backproject the attenuation measurements of the object, including the more than two conjugate samples, to reconstruct at least one image slice of the object.

16. A system in accordance with Claim 15 further configured so that the more than two conjugate samples are located within a predetermined distance from the plane of reconstruction of the object.

17. A system in accordance with Claim 16 having N detector rows, and further configured to perform the helical scan at a pitch $P:1$, where P is a non-integer less than N .

18. A system in accordance with Claim 17 wherein $N=4$ and $P=2.5$.

19. A system in accordance with Claim 15 further comprising configured to apply a non-linear interpolation to the attenuation measurements prior to said filtering and backprojecting.

20. A system in accordance with Claim 19 wherein said system being configured to apply a non-linear interpolation to the attenuation measurements comprises said system being configured to apply a Lagrange interpolation to the attenuation measurements.

21. A system in accordance with Claim 20 wherein said system being configured to apply a Lagrange interpolation to the attenuation measurements comprises said system being configured to apply third order Lagrange interpolation weights to measurements from four detector rows.

22. A system in accordance with Claim 19 having 4 detector rows, and wherein said system being configured to helically scan the object to obtain attenuation measurements comprises said system being configured to helically scan the object at a pitch of 2.5:1, and said system is further configured to estimate projections along a curved plane written as $\beta'_1 = 2.8\pi - \gamma$, $\beta'_2 = 2\pi - \gamma$, $\beta'_3 = 1.2\pi - \gamma$, and $\beta'_4 = 0.4\pi - \gamma$, where $\beta'_1, \beta'_2, \beta'_3$, and β'_4 represent view angles in a curved plane for corresponding detector rows R1, R2, R3, and R4, respectively, and γ represents a detector angle.

23. A system in accordance with claim 19 wherein said system being configured to apply a non-linear interpolation to the attenuation measurements comprises said system being configured to combine weighted interpolated measurements with weighted extrapolated measurements.

24. A system in accordance with Claim 23 having 4 detector rows R1, R2, R3, and R4, wherein said system being configured to helically scan the object to obtain attenuation measurements comprises said system being configured to helically scan the object at a pitch of 2.5:1, and said system is further configured to apply

weights to attenuation measurements for detector rows R1, R2, R3, and R4 respectively, wherein the applied weights are written as:

$$w_1(\gamma, \beta) =$$

$$\left\{ \begin{array}{ll} \left[\left(\frac{5\theta_1 + 2\pi}{2\pi} \right)^\alpha + \left(\frac{-5\theta_1}{2\pi} \right)^\alpha \right] \left(\frac{5\theta_1 + 2\pi}{2\pi} \right), & \beta'_1 - \frac{2\pi}{5} \leq \beta < \beta'_1 - \frac{\pi}{5} \\ \left[1 - \left(\frac{5\theta_1 + 2\pi}{2\pi} \right)^\alpha - \left(\frac{-5\theta_1}{2\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_1}{\pi} \right) + \\ \left[\left(\frac{5\theta_1 + 2\pi}{2\pi} \right)^\alpha + \left(\frac{-5\theta_1}{2\pi} \right)^\alpha \right] \left(\frac{5\theta_1 + 2\pi}{2\pi} \right), & \beta'_1 - \frac{\pi}{5} \leq \beta < \beta'_1 \\ \left[\left(\frac{5\theta_1}{\pi} \right)^\alpha + \left(\frac{\pi - 5\theta_1}{\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_1}{\pi} \right), & \beta'_1 \leq \beta < \beta'_1 + \frac{\pi}{5} \end{array} \right.$$

$$\text{where } \theta_1 = \beta - \beta'_1 = \beta - 2.8\pi + \gamma,$$

$$w_2(\gamma, \beta) =$$

$$\left\{ \begin{array}{ll} \left[1 - \left(\frac{5\theta_2 + 3\pi}{2\pi} \right)^\alpha - \left(\frac{-5\theta_2 - \pi}{2\pi} \right)^\alpha \right] \left(\frac{5\theta_2 + \pi}{\pi} \right), & \beta'_2 - \frac{2\pi}{5} \leq \beta < \beta'_2 - \frac{\pi}{5} \\ \left[1 - \left(\frac{5\theta_2 + \pi}{\pi} \right)^\alpha - \left(\frac{-5\theta_2}{\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_2}{\pi} \right) + \\ \left[\left(\frac{5\theta_2 + \pi}{\pi} \right)^\alpha + \left(\frac{-5\theta_2}{\pi} \right)^\alpha \right] \left(\frac{5\theta_2 + \pi}{\pi} \right), & \beta'_2 - \frac{\pi}{5} \leq \beta < \beta'_2 \\ \left[\left(\frac{5\theta_2}{\pi} \right)^\alpha + \left(\frac{\pi - 5\theta_2}{\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_2}{\pi} \right), & \beta'_2 \leq \beta < \beta'_2 + \frac{\pi}{5} \\ \left[1 - \left(\frac{5\theta_2 - \pi}{\pi} \right)^\alpha - \left(\frac{2\pi - 5\theta_2}{\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_2}{\pi} \right), & \beta'_2 + \frac{\pi}{5} \leq \beta < \beta'_2 + \frac{2\pi}{5} \end{array} \right.$$

$$\text{where } \theta_2 = \beta - \beta'_2 = \beta - 2\pi + \gamma,$$

$$w_3(\gamma, \beta) =$$

$$\left\{ \begin{array}{ll} \left[1 - \left(\frac{5\theta_3 + 2\pi}{\pi} \right)^\alpha - \left(\frac{-5\theta_3 - \pi}{\pi} \right)^\alpha \right] \left(\frac{5\theta_3 + \pi}{\pi} \right) & \beta'_3 - \frac{2\pi}{5} \leq \beta < \beta'_3 - \frac{\pi}{5} \\ \left[1 - \left(\frac{5\theta_3 + \pi}{\pi} \right)^\alpha - \left(\frac{-5\theta_3}{\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_3}{\pi} \right) + \\ \left[\left(\frac{5\theta_3 + \pi}{\pi} \right)^\alpha + \left(\frac{-5\theta_3}{\pi} \right)^\alpha \right] \left(\frac{5\theta_3 + \pi}{\pi} \right) & \beta'_3 - \frac{\pi}{5} \leq \beta < \beta'_3 \\ \left[1 - \left(\frac{5\theta_3}{\pi} \right)^\alpha - \left(\frac{\pi - 5\theta_3}{\pi} \right)^\alpha \right] \left(\frac{\pi + 5\theta_3}{\pi} \right) + \\ \left[\left(\frac{5\theta_3}{\pi} \right)^\alpha + \left(\frac{\pi - 5\theta_3}{\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_3}{\pi} \right) & \beta'_3 \leq \beta < \beta'_3 + \frac{\pi}{5} \\ \left[1 - \left(\frac{5\theta_3 - \pi}{2\pi} \right)^\alpha - \left(\frac{3\pi - 5\theta_3}{2\pi} \right)^\alpha \right] \left(\frac{\pi - 5\theta_3}{\pi} \right) & \beta'_3 + \frac{\pi}{5} \leq \beta < \beta'_3 + \frac{2\pi}{5} \end{array} \right.$$

where $\theta_3 = \beta - \beta'_3 = \beta - 1.2\pi + \gamma$, and

$$w_4(\gamma, \beta) =$$

$$\left\{ \begin{array}{ll} \left[1 - \left(\frac{5\theta_4 + 2\pi}{\pi} \right)^a - \left(\frac{-5\theta_4 - \pi}{\pi} \right)^a \right] \left(\frac{5\theta_4 + \pi}{\pi} \right) & \beta'_4 - \frac{2\pi}{5} \leq \beta < \beta'_4 - \frac{\pi}{5} \\ \left[\left(\frac{5\theta_4 + \pi}{\pi} \right)^a + \left(\frac{-5\theta_4}{\pi} \right)^a \right] \left(\frac{\pi + 5\theta_4}{\pi} \right) & \beta'_4 - \frac{\pi}{5} \leq \beta < \beta'_4 \\ \left[1 - \left(\frac{5\theta_4}{2\pi} \right)^a - \left(\frac{2\pi - 5\theta_4}{2\pi} \right)^a \right] \left(\frac{\pi + 5\theta_4}{\pi} \right) + \\ \left[\left(\frac{5\theta_4}{2\pi} \right)^a + \left(\frac{2\pi - 5\theta_4}{2\pi} \right)^a \right] \left(\frac{2\pi - 5\theta_4}{2\pi} \right) & \beta'_4 \leq \beta < \beta'_4 + \frac{\pi}{5} \\ \left[\left(\frac{5\theta_4}{2\pi} \right)^a + \left(\frac{2\pi - 5\theta_4}{2\pi} \right)^a \right] \left(\frac{2\pi - 5\theta_4}{2\pi} \right) & \beta'_4 + \frac{\pi}{5} \leq \beta < \beta'_4 + \frac{2\pi}{5} \end{array} \right.$$

$$\text{where } \theta_4 = \beta - \beta'_4 = \beta - 0.4\pi + \gamma,$$

$$\beta'_1 = 2.8\pi - \gamma, \beta'_2 = 2\pi - \gamma, \beta'_3 = 1.2\pi - \gamma, \text{ and } \beta'_4 = 0.4\pi - \gamma;$$

$\beta'_1, \beta'_2, \beta'_3,$ and β'_4 represent view angles intersecting the POR for

5 detector rows R1, R2, R3, and R4, respectively, and

γ represents a detector angle.

25. A system in accordance with Claim 15 further configured to apply a set of weights to the attenuation measurements prior to said filtering and backprojecting.

10 26. A system in accordance with Claim 25 wherein said system being configured to apply a set of weights to the attenuation measurements comprises said system being configured to apply Lagrange weights to the attenuation measurements.

27. A system in accordance with Claim 26 wherein said system being configured to apply Lagrange weights to the attenuation measurements comprises said system being configured to apply third order Lagrange weights to measurements from four detector rows.

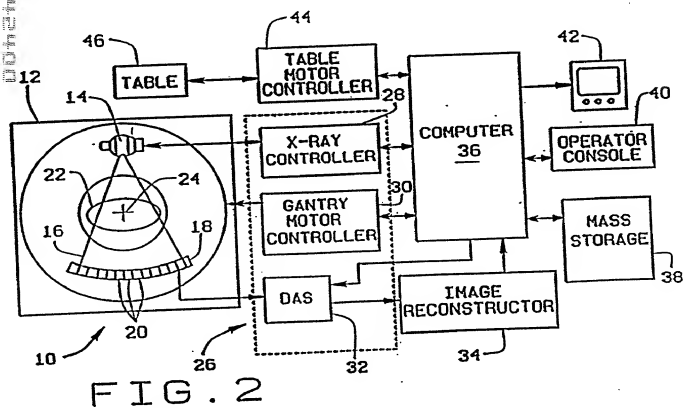
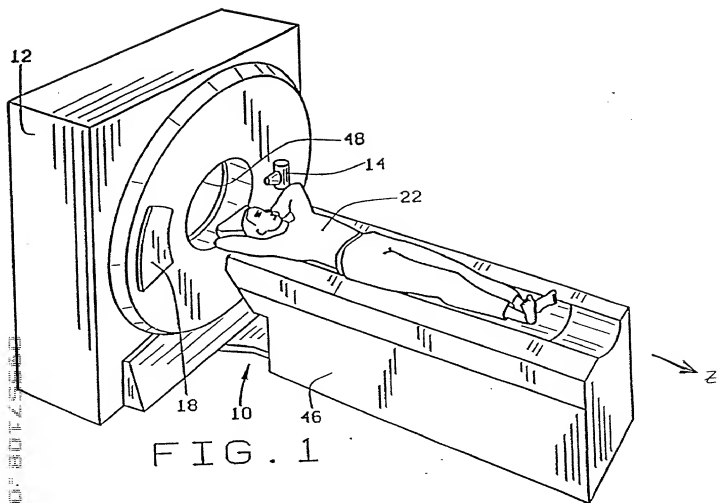
28. A system in accordance with Claim 15 having 4 detector rows, and said system being configured to helically scan the object to obtain attenuation measurements comprises said system being configured to helically scan the object at a pitch of 2.5:1, and said system is further configured to estimate projections along a curved plane written as $\beta'_1 = 2.8\pi - \gamma$, $\beta'_2 = 2\pi - \gamma$, $\beta'_3 = 1.2\pi - \gamma$, and $\beta'_4 = 0.4\pi - \gamma$, where $\beta'_1, \beta'_2, \beta'_3$, and β'_4 represent view angles in a curved plane for corresponding detector rows R1, R2, R3, and R4, respectively, and γ represents a detector angle.

METHODS AND APPARATUS FOR HELICAL RECONSTRUCTION FOR MULTISLICE CT SCAN

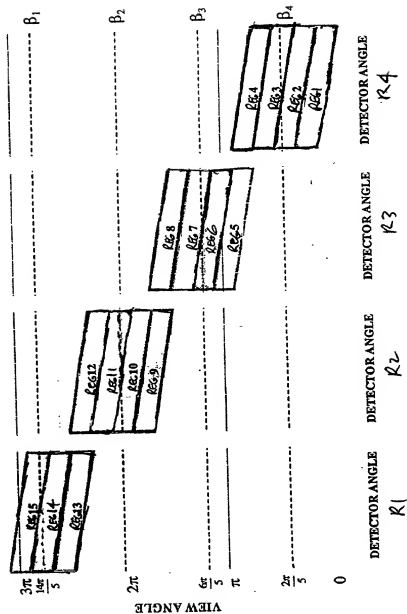
ABSTRACT OF THE DISCLOSURE

One embodiment of the present invention is a method for imaging an object with a computed tomographic (CT) imaging system that includes steps of helically scanning the object with a multi-slice CT imaging system to acquire attenuation measurements of the object, the measurements including more than two conjugate samples for estimation of a projection at a plane of reconstruction of the object; and filtering and backprojecting the attenuation measurements of the object, including the more than two conjugate samples, to reconstruct at least one image slice of the object. An improved sampling pattern and better use of the attenuation samples obtained during a scan is thus provided.

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0656 0657 0658 0659 0660 0661 0662 0663 0664 0665 0666 0667 0668 0669 0670 0671 0672 0673 0674 0675 0676 0677 0678 0679 0680 0681 0682 0683 0684 0685 0686 0687 0688 0689 0690 0691 0692 0693 0694 0695 0696 0697 0698 0699 0700 0701 0702 0703 0704 0705 0706 0707 0708 0709 0710 0711 0712 0713 0714 0715 0716 0717 0718 0719 0720 0721 0722 0723 0724 0725 0726 0727 0728 0729 0730 0731 0732 0733 0734 0735 0736 0737 0738 0739 0740 0741 0742 0743 0744 0745 0746 0747 0748 0749 0750 0751 0752 0753 0754 0755 0756 0757 0758 0759 0760 0761 0762 0763 0764 0765 0766 0767 0768 0769 0770 0771 0772 0773 0774 0775 0776 0777 0778 0779 0780 0781 0782 0783 0784 0785 0786 0787 0788 0789 0790 0791 0792 0793 0794 0795 0796 0797 0798 0799 0800 0801 0802 0803 0804 0805 0806 0807 0808 0809 0810 0811 0812 0813 0814 0815 0816 0817 0818 0819 0820 0821 0822 0823 0824 0825 0826 0827 0828 0829 0830 0831 0832 0833 0834 0835 0836 0837 0838 0839 0840 0841 0842 0843 0844 0845 0846 0847 0848 0849 0850 0851 0852 0853 0854 0855 0856 0857 0858 0859 0860 0861 0862 0863 0864 0865 0866 0867 0868 0869 0870 0871 0872 0873 0874 0875 0876 0877 0878 0879 0880 0881 0882 0883 0884 0885 0886 0887 0888 0889 0890 0891 0892 0893 0894 0895 0896 0897 0898 0899 0900 0901 0902 0903 0904 0905 0906 0907 0908 0909 0910 0911 0912 0913 0914 0915 0916 0917 0918 0919 0920 0921 0922 0923 0924 0925 0926 0927 0928 0929 0930 0931 0932 0933 0934 0935 0936 0937 0938 0939 0940 0941 0942 0943 0944 0945 0946 0947 0948 0949 0950 0951 0952 0953 0954 0955 0956 0957 0958 0959 0960 0961 0962 0963 0964 0965 0966 0967 0968 0969 0970 0971 0972 0973 0974 0975 0976 0977 0978 0979 0980 0981 0982 0983 0984 0985 0986 0987 0988 0989 0990 0991 0992 0993 0994 0995 0996 0997 0998 0999 1000 1001 1002 1003 1004 1005 1006 1007 1008 1009 1010 1011 1012 1013 1014 1015 1016 1017 1018 1019 1020 1021 1022 1023 1024 1025 1026 1027 1028 1029 1030 1031 1032 1033 1034 1035 1036 1037 1038 1039 1040 1041 1042 1043 1044 1045 1046 1047 1048 1049 1050 1051 1052 1053 1054 1055 1056 1057 1058 1059 1060 1061 1062 1063 1064 1065 1066 1067 1068 1069 1070 1071 1072 1073 1074 1075 1076 1077 1078 1079 1080 1081 1082 1083 1084 1085 1086 1087 1088 1089 1090 1091 1092 1093 1094 1095 1096 1097 1098 1099 1100 1101 1102 1103 1104 1105 1106 1107 1108 1109 1110 1111 1112 1113 1114 1115 1116 1117 1118 1119 1120 1121 1122 1123 1124 1125 1126 1127 1128 1129 1130 1131 1132 1133 1134 1135 1136 1137 1138 1139 1140 1141 1142 1143 1144 1145 1146 1147 1148 1149 1150 1151 1152 1153 1154 1155 1156 1157 1158 1159 1160 1161 1162 1163 1164 1165 1166 1167 1168 1169 1170 1171 1172 1173 1174 1175 1176 1177 1178 1179 1180 1181 1182 1183 1184 1185 1186 1187 1188 1189 1190 1191 1192 1193 1194 1195 1196 1197 1198 1199 1200 1201 1202 1203 1204 1205 1206 1207 1208 1209 1210 1211 1212 1213 1214 1215 1216 1217 1218 1219 1220 1221 1222 1223 1224 1225 1226 1227 1228 1229 1230 1231 1232 1233 1234 1235 1236 1237 1238 1239 1240 1241 1242 1243 1244 1245 1246 1247 1248 1249 1250 1251 1252 1253 1254 1255 1256 1257 1258 1259 1260 1261 1262 1263 1264 1265 1266 1267 1268 1269 1270 1271 1272 1273 1274 1275 1276 1277 1278 1279 1280 1281 1282 1283 1284 1285 1286 1287 1288 1289 1290 1291 1292 1293 1294 1295 1296 1297 1298 1299 1300 1301 1302 1303 1304 1305 1306 1307 1308 1309 1310 1311 1312 1313 1314 1315 1316 1317 1318 1319 1320 1321 1322 1323 1324 1325 1326 1327 1328 1329 1330 1331 1332 1333 1334 1335 1336 1337 1338 1339 1340 1341 1342 1343 1344 1345 1346 1347 1348 1349 1350 1351 1352 1353 1354 1355 1356 1357 1358 1359 1360 1361 1362 1363 1364 1365 1366 1367 1368 1369 1370 1371 1372 1373 1374 1375 1376 1377 1378 1379 1380 1381 1382 1383 1384 1385 1386 1387 1388 1389 1390 1391 1392 1393 1394 1395 1396 1397 1398 1399 1400 1401 1402 1403 1404 1405 1406 1407 1408 1409 1410 1411 1412 1413 1414 1415 1416 1417 1418 1419 1420 1421 1422 1423 1424 1425 1426 1427 1428 1429 1430 1431 1432 1433 1434 1435 1436 1437 1438 1439 1440 1441 1442 1443 1444 1445 1446 1447 1448 1449 1450 1451 1452 1453 1454 1455 1456 1457 1458 1459 1460 1461 1462 1463 1464 1465 1466 1467 1468 1469 1470 1471 1472 1473 1474



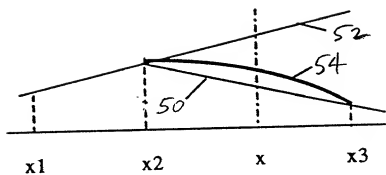


Fig. 4

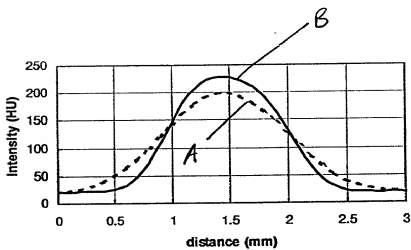


Fig. 5

DECLARATION AND POWER OF ATTORNEY

Attorney's Docket No.

15-CT-5344

As a below named inventor, I hereby declare that:

My residence, post office address and citizenship are as stated below next to my name.

I believe I am the original, first and sole inventor (if only one name is listed below) or an original, first and joint inventor (if plural names are listed below) of the subject matter which is claimed and for which a patent is sought on the invention entitled: **METHODS AND APPARATUS FOR HELICAL RECONSTRUCTION FOR MULTISLICE CT SCAN**, the specification of which:

(check one) ☒ is attached hereto
☐ was filed on _____ as Application Serial No. _____,
and was amended on _____.

I hereby state that I have reviewed and understand the contents of the above identified specification, including the claims, as amended by any amendment referred to above.

I acknowledge the duty to disclose information which is material to the examination of this application in accordance with Title 37, Code of Federal Regulations §1.56(a).

I hereby claim priority benefits under Title 35, United States Code, §120 of any United States application(s) listed below and, insofar as the subject matter of each of the claims of this application is not disclosed in the prior United States application in the manner provided by the first paragraph of Title 35, United States Code, §112. I acknowledge the duty to disclose material information as defined in Title 37, Code of Federal Regulations, §1.56(a) which occurred between the filing date of the prior application and the national or PCT international filing date of this application:

Application Serial No.	Filing Date	Status (patented, pending, abandoned)
_____	_____	_____
_____	_____	_____
_____	_____	_____

I hereby claim the benefit under Title 35, United States Code §119(c) of any United States provisional application(s) listed below:

Application Serial No.	Filing Date	Additional provisional application numbers are listed on a supplemental priority sheet attached hereto.
_____	_____	_____
_____	_____	_____
_____	_____	_____

POWER OF ATTORNEY: As a named inventor, I hereby appoint the following attorney(s) and/or agent(s) to prosecute this application and transact all business in the Patent and Trademark Office connected therewith. (list name and registration number)

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Attorney's Docket No.

15-CT-5344

I hereby declare that all statements made herein of my own knowledge are true and that all statements made on information and belief are believed to be true; and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under Section 1001 of Title 18 of the United States Code and that such willful false statements may jeopardize the validity of the application and any patent issued thereon.

SOLE OR FIRST INVENTOR:

Full Name: Jiang HsiehSignature: Date: 4/18/00Residence: Brookfield, Wisconsin 53045Citizenship: U.S.A.Post Office Address: 19970 W. Keswick Ct., Brookfield, Wisconsin 53045

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